

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/813,410	CHANG ET AL.	
Examiner		Art Unit	Yogesh C. Garg	
		3625	Page 1 of 1	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0035450 A1	03-2002	Thackston, James D.	703/1
*	B	US-2003/0069824 A1	04-2003	Menninger, Anthony Frank	705/37
*	C	US-2003/0014326 A1	01-2003	Ben-Meir et al.	705/26
*	D	US-2003/0074301 A1	04-2003	Solomon, Neal	705/37
*	E	US-2002/0042769 A1	04-2002	Gujral et al.	705/37
*	F	US-7,146,331	12-2006	Young, Erik P.	705/26
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.